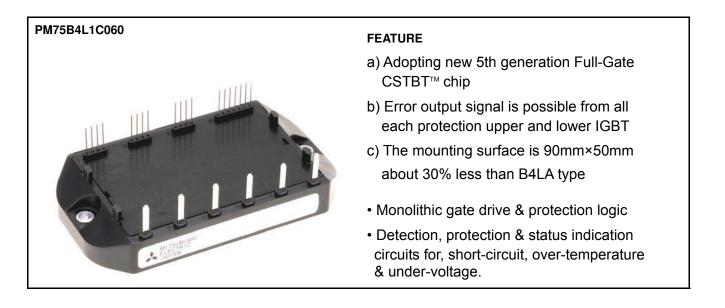
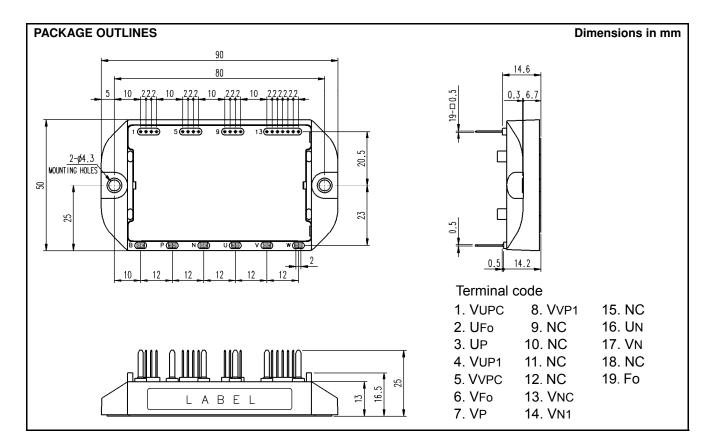
FLAT-BASE TYPE INSULATED PACKAGE



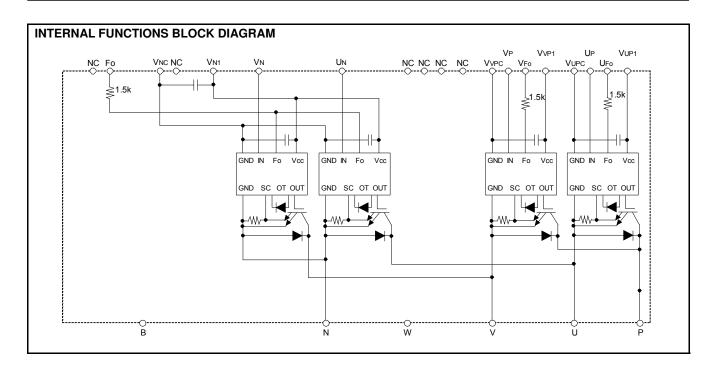
APPLICATION

Photo voltaic power conditioner





FLAT-BASE TYPE INSULATED PACKAGE



MAXIMUM RATINGS ($T_j = 25^{\circ}C$, unless otherwise noted) **INVERTER PART**

Symbol	Parameter	Conditions	Ratings	Unit
V _{CES}	Collector-Emitter Voltage	V _D =15V, V _{CIN} =15V	600	V
lc	Collector Current	T _c =25°C	75	A
I _{CRM}		Pulse	150	~
P _{tot}	Total Power Dissipation	T _c =25°C	201	W
IE	Emitter Current	T _c =25°C	75	٨
I _{ERM}	(Free wheeling Diode Forward current)	Pulse	150	A
Tj	Junction Temperature		-20 ~ +150	°C

*: Tc measurement point is just under the chip.

CONTROL PART

Symbol	Parameter	Conditions	Ratings	Unit
VD	Supply Voltage	Applied between : V_{UP1} - V_{UPC} , V_{VP1} - V_{VPC} , V_{N1} - V_{NC}	20	V
V _{CIN}	Input Voltage	Applied between : UP-V _{UPC} , VP-V _{VPC} , UN \cdot VN-V _{NC}	20	V
V _{FO}	Fault Output Supply Voltage	Applied between : UFo-V _{UPC} , VFo-V _{VPC} , Fo-V _{NC}	20	V
I _{FO}	Fault Output Current	Sink current at UFo, VFo, Fo terminals	20	mA



FLAT-BASE TYPE INSULATED PACKAGE

TOTAL SYSTEM

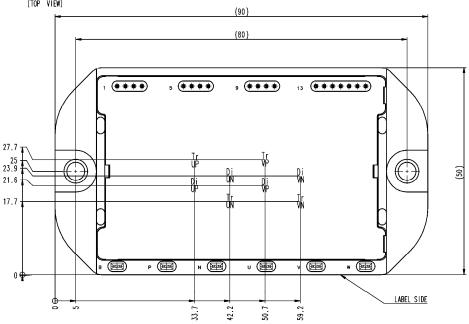
Symbol	Parameter	Conditions	Ratings	Unit
V _{CC(PROT)}	Supply Voltage Protected by SC	$V_D = 13.5V \sim 16.5V$ Inverter Part, T _i =+125°C Start	450	V
V _{CC(surge)}	Supply Voltage (Surge)	Applied between : P-N, Surge value	500	V
T _{stg}	Storage Temperature		-40 ~ +125	°C
V _{isol}	Isolation Voltage	60Hz, Sinusoidal, Charged part to Base plate, AC 1min, RMS	2500	V

*: T_c measurement point is just under the chip.

THERMAL RESISTANCE

Symbol	Parameter	Conditions		Limits			Unit
Symbol	i arameter			Min.	Тур.	Max.	Onic
R _{th(j-c)Q}	Thermal Resistance	Junction to case, IGBT (per 1 element)	(Note.1)	-	-	0.62	
R _{th(j-c)D}		Junction to case, FWDi (per 1 element)	(Note.1)	-	-	1.06	к/w
R _{th(c-s)}	Contact Thermal Resistance	Case to heat sink, (per 1 module) Thermal grease applied	(Note.1)	-	0.06	-	r\/ v v

Note 1: If you use this value, $R_{th(s:a)}$ should be measured just under the chips. [TOP VIEW]



ELECTRICAL CHARACTERISTICS (Tj = 25°C, unless otherwise noted) **INVERTER PART**

Symbol	Parameter	Conc	Conditions		Conditions				Unit
Symbol	Falametei	Conc			Min.	Тур.	Max.	Onit	
V _{CEsat}	Collector-Emitter Saturation	V _D =15V, I _C =75A		Tj=25°C	-	2.2	2.7	V	
V CEsat	Voltage	V _{CIN} =0V, Pulsed (Fig. 1)	foltage $V_{CIN}=0V$, Pulsed (Fig. 1) $T_j=125^{\circ}C$	T _j =125°C	-	2.2	2.7	v	
V _{EC}	Emitter-Collector Voltage	I _E =75A, V _D =15V, V _{CIN} = 15V		(Fig. 2)	-	2.4	3.3	V	
t _{on}					0.1	0.5	1.2		
trr	1	$V_D=15V, V_{CIN}=0V \leftrightarrow 15V$			-	0.1	0.2		
t _{c(on)}	Switching Time	V _{CC} =300V, I _C =75A T _i =125°C			-	0.15	0.3	μs	
t _{off}		Inductive Load		(Fig. 3,4)	-	1.1	2.0		
t _{c(off)}				(-	0.2	0.4		
	Collector-Emitter Cut-off	V _{CE} =V _{CES} , V _D =15V , V _{CIN} =1		T _j =25°C	-	-	1	mA	
I _{CES}	Current	V CE- V CES, V D- 15V, V CIN- 15	5v (ng. 5)	T _j =125°C	-	-	10	ШA	



FLAT-BASE TYPE INSULATED PACKAGE

CONTROL PART

Symbol	Parameter	Conditions			Limits		Unit
Symbol	Falameter Condi			Min.	Тур.	Max.	Unit
I _D	Circuit Current	V _D =15V, V _{CIN} =15V	V _{N1} -V _{NC}	-	6.5	12	mA
טי	Circuit Current	$v_{\rm D}$ = 15v, $v_{\rm CIN}$ = 15v	V*P1-V*PC	-	1.6	4.0	IIIA
V _{th(ON)}	Input ON Threshold Voltage	Applied between : UP-V _{UPC} , VP-V _{VPC} , UN·VN-V _{NC}		1.2	1.5	1.8	v
$V_{\text{th(OFF)}}$	Input OFF Threshold Voltage			1.7	2.0	2.3	v
SC	Short Circuit Trip Level	-20≤Tj≤125°C, V _D =15V	(Fig. 3, 6)	112	-	-	Α
$t_{\text{off}(\text{SC})}$	Short Circuit Current Delay Time	V _D =15V	(Fig. 3, 6)	-	0.2	-	μS
OT	Over Temperature Drotestion		Trip level	135	-	-	°C
OT _(hys)	Over Temperature Protection	Detect Temperature of IGBT chip	Hysteresis	-	20	-	
UVt	Supply Circuit Under-Voltage	-20≤Ti≤125°C	Trip level	11.5	12.0	12.5	V
UVr	Protection	-205135125 C	Reset level	-	12.5	-	V
I _{FO(H)}	Foult Output Current	ault Output Current V _D =15V, V _{FO} =15V	(Nata 2)	-	-	0.01	
I _{FO(L)}			(Note.2)	-	10	15	mA
t _{FO}	Fault Output Pulse Width	V _D =15V	(Note.2)	1.0	1.8	-	ms

Note.2: Fault output is given only when the internal SC, OT & UV protections schemes of either upper or lower arm device operate to protect it.

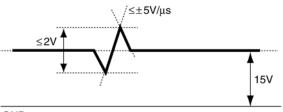
MECHANICAL RATINGS AND CHARACTERISTICS

Symbol	Parameter	Conditions		Limits		
Symbol	Falameter	Conditions	Min.	Тур.	Max.	Unit
Ms	Mounting Torque	Mounting part screw : M4	1.4	1.65	1.9	N∙m
m	Weight	-	-	135	-	g

RECOMMENDED CONDITIONS FOR USE

Symbol	Parameter	Conditions	Recommended value	Unit
V _{CC}	Supply Voltage	Applied across P-N terminals	≤ 450	V
VD	Control Supply Voltage	$\begin{array}{c} \mbox{Applied between : } V_{UP1} - V_{UPC}, \\ V_{VP1} - V_{VPC}, V_{N1} - V_{NC} \end{array} (Note.3) \end{array}$	15.0±1.5	V
V _{CIN(ON)}	Input ON Voltage	Applied between : UP-V _{UPC} , VP-V _{VPC} , UN · VN-V _{NC}	≤ 0.8	V
$V_{\text{CIN(OFF)}}$	Input OFF Voltage		≥ 9.0	v
f _{PWM}	PWM Input Frequency	Using Application Circuit of Fig. 8	≤ 20	kHz
\mathbf{t}_{dead}	Arm Shoot-through Blocking Time	For IPM's each input signals (Fig. 7)	≥ 2.0	μS
lo	Module Operating Current	RMS	≤ 30	А

Note.3: With ripple satisfying the following conditions: dv/dt swing ≤ ±5V/µs, Variation ≤ 2V peak to peak



GND



Vcc

Fo

IN

GNE

Fig. 2 V_{EC} Test

Irr

lc

10%

td(off)

tc(off)

U,V,(N)

Fo

Vci

90%

(ton = td(on) + tr)

10%

tc(on)

V_{CIN}

PM75B4L1C060

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V)

VCE

10%

tf

(toff = td(off) + tf)

90%

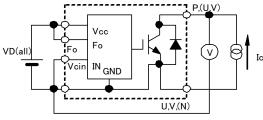
Ic

PRECAUTIONS FOR TESTING

- 1. Before applying any control supply voltage (V_D), the input terminals should be pulled up by resistors, etc. to their corresponding supply voltage and each input signal should be kept off state.
 - After this, the specified ON and OFF level setting for each input signal should be done.
- 2. When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above V_{CES} rating of the device.

VD(all)

(These test should not be done by using a curve tracer or its equivalent.)





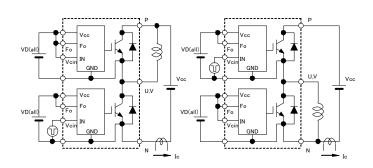
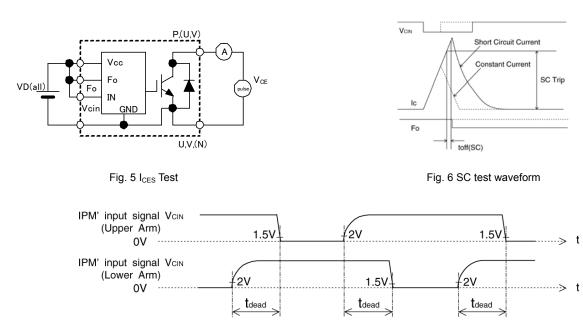


Fig. 3 Switching time and SC test circuit



1.5V: Input on threshold voltage Vth(on) typical value, 2V: Input off threshold voltage Vth(off) typical value





5

Fig. 4 Switching time test waveform

FLAT-BASE TYPE INSULATED PACKAGE

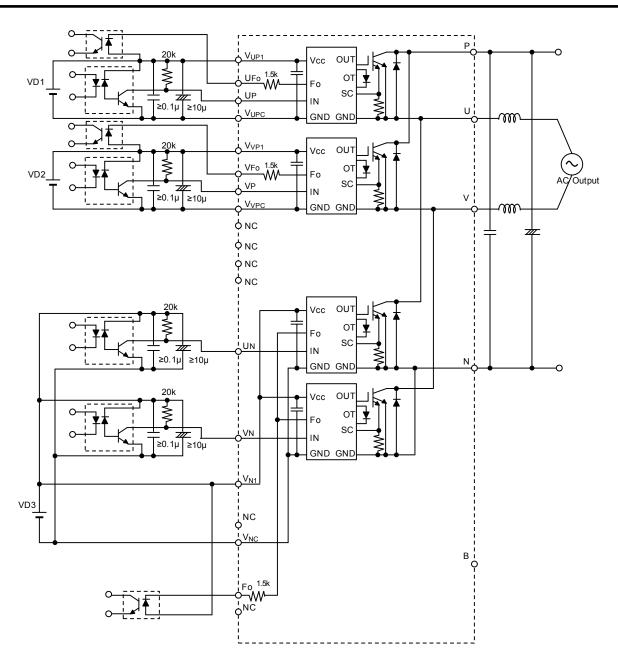


Fig. 8 Application Example Circuit

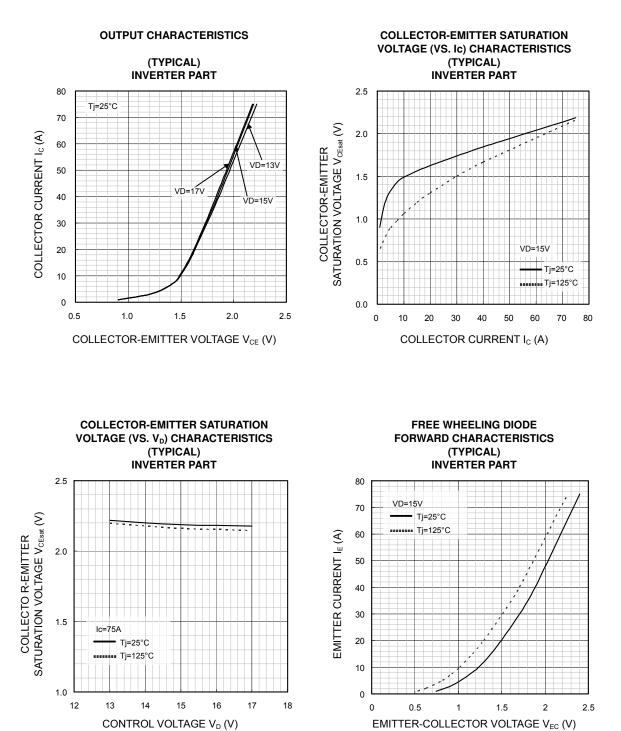
NOTES FOR STABLE AND SAFE OPERATION ;

- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers: t_{PLH} , $t_{PHL} \le 0.8 \mu s$, Use High CMR type.
- Slow switching opto-coupler: CTR > 100%
- Use 3 isolated control power supplies (V_D). Also, care should be taken to minimize the instantaneous voltage charge of the power supply.
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between P and N terminal.

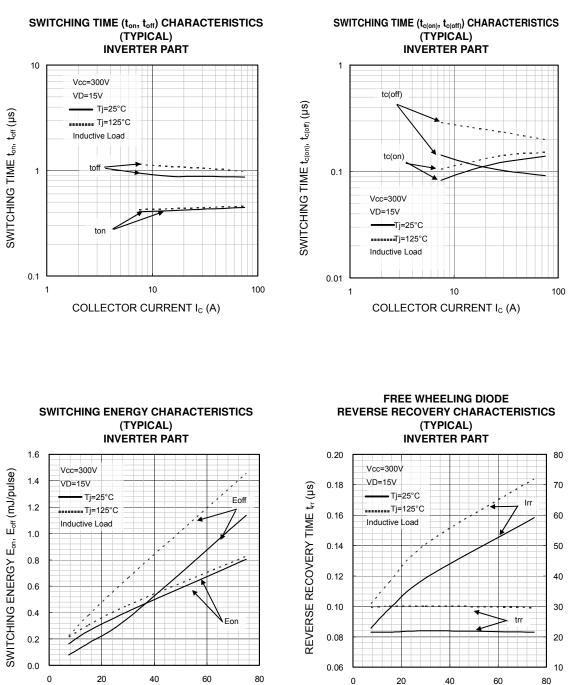


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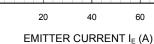
PERFORMANCE CURVES



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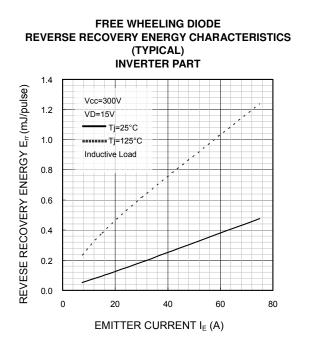


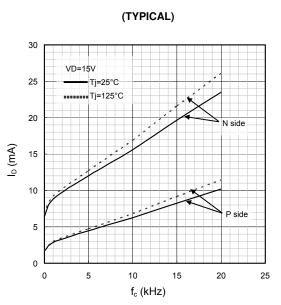
COLLECTOR CURRENT Ic (A)



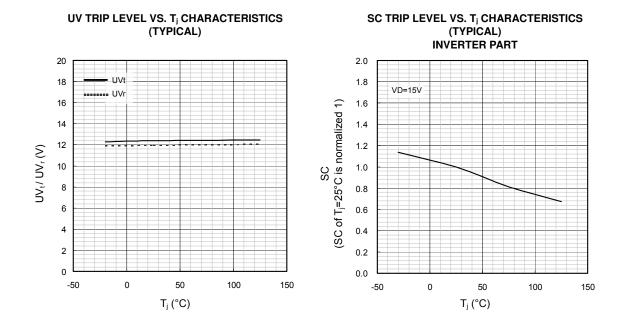
REVERSE RECOVERY CURRENT In (A)

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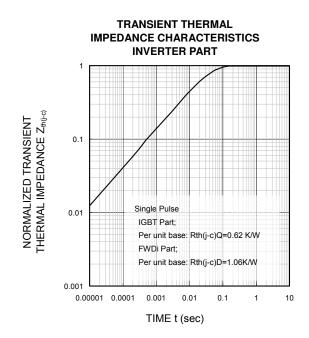




I_D VS. f_c CHARACTERISTICS



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